

# Testing the rank of the volatility process: A random perturbation approach

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# Outline

- ▶ Formulation of the statistical problem
- ▶ Random perturbation of the original data
- ▶ Asymptotic theory
- ▶ Testing procedure

# Continuous diffusion processes

- ▶ We consider a  $d$ -dimensional continuous diffusion process of the form

$$X_t = X_0 + \int_0^t a_s ds + \int_0^t \sigma_s dW_s, \quad t \in [0, 1].$$

In this model

- ▶  $\sigma$  is a  $\mathbb{R}^{d \times d}$ -valued volatility process
  - ▶  $a$  is a  $d$ -dimensional drift process
  - ▶  $W$  is a  $d$ -dimensional Brownian motion
- 
- ▶ We observe high frequency data

$$X_0, X_{\Delta_n}, X_{2\Delta_n}, \dots, X_{[1/\Delta_n]\Delta_n}$$

with  $\Delta_n \rightarrow 0$ .

# The statistical problem

- ▶ Let  $r$  denote the rank of the matrix  $c = \sigma\sigma^*$ , i.e.

$$r_t = \text{rank}(c_t), \quad t \in [0, 1].$$

Our aim is to estimate/test the maximal rank of  $c$  during a given trading day  $[0, 1]$ . Hence, our object of interest is given via

$$R = \sup_{t \in [0, 1]} r_t.$$

- ▶ We remark that the set  $\{t \in [0, 1] \mid r_t = R\}$  has positive Lebesgue measure if  $\sigma$  is a continuous process.
- ▶ Warning: The random variable  $R$  has no connection to the integrated volatility matrix, i.e.

$$R \neq \text{rank}\left(\int_0^1 c_s ds\right).$$

## A perturbation method

We explain the basic idea on a non-random problem. Let  $A \in \mathbb{R}^{d \times d}$  be a given positive semidefinite matrix with  $r = \text{rank}(A)$ . We consider a positive definite matrix  $B \in \mathbb{R}^{d \times d}$  and a number  $h \searrow 0$ . By the multilinearity of the determinant we obtain the identity

$$\det(A + hB) = h^{d-r} \gamma_{A,B} + O(h^{d-r+1})$$

with  $\gamma_{A,B} := \sum_{C \in \mathcal{M}_{A,B}} \det(C)$  and

$\mathcal{M}_{A,B} := \{C \in \mathbb{R}^{d \times d} : C_i = A_i \text{ or } C_i = B_i, \text{ A and C share } r \text{ joint columns}\}$ ,

where  $A = (A_1, \dots, A_d)$  and  $B = (B_1, \dots, B_d)$ . When  $\gamma_{A,B} \neq 0$ , we deduce that

$$\frac{\det(A + 2hB)}{\det(A + hB)} \rightarrow 2^{d-r} \quad \text{as } h \searrow 0.$$

## A simple example

Let  $A = (A_1, A_2, A_3), B = (B_1, B_2, B_3) \in \mathbb{R}^{3 \times 3}$  and  $r = \text{rank}(A) = 1$ .  
Then it holds that

$$\begin{aligned} \det(A + hB) &= \underbrace{\det(A_1, A_2, A_3)}_{=0} \\ &+ h \underbrace{[\det(A_1, A_2, B_3) + \det(A_1, B_2, A_3) + \det(B_1, A_2, A_3)]}_{=0} \\ &+ h^2 \underbrace{[\det(A_1, B_2, B_3) + \det(B_1, A_2, B_3) + \det(B_1, B_2, A_3)]}_{=\gamma_{A,B}} \\ &+ \underbrace{h^3 \det(B_1, B_2, B_3)}_{=O(h^3)} \end{aligned}$$

## Some remarks

- ▶ Although our application of random perturbation method to diffusion is new, there exist similar ideas in other fields. Let us mention the following
  - ▶ Functional analysis  $\rightarrow$  Tikhonov regularization
  - ▶ Statistical inverse problems
  - ▶ Linear regression  $\rightarrow$  ridge regression
  - ▶ Signal-noise models
- ▶ When the matrix  $A$  is not directly observed, we cannot choose a matrix  $B$  such that

$$\gamma_{A,B} \neq 0.$$

However, in the stochastic setting the choice  $B = (B_1, \dots, B_d)$ ,  $(B_i)$  iid  $\mathcal{N}_d(0, I_d)$ , independent of  $A$ , guarantees that  $\gamma_{A,B} \neq 0$  almost surely.

# The test statistic

- ▶ First, we introduce a random perturbation of the original diffusion process

$$Z_t^n = X_t + \sqrt{\Delta_n} \widehat{W}_t,$$

where  $\widehat{W}$  is a new Brownian motion independent of everything.

- ▶ The test statistic  $S(Z^n, \Delta_n)$  is defined via

$$S(Z^n, \Delta_n) = \sum_{i=1}^{\lfloor 1/\Delta_n \rfloor - d + 1} \det^2 \left( \Delta_i^n Z^n / \sqrt{\Delta_n}, \dots, \Delta_{i+d-1}^n Z^n / \sqrt{\Delta_n} \right)$$

with  $\Delta_i^n Z^n = Z_{i\Delta_n}^n - Z_{(i-1)\Delta_n}^n$ .

- ▶ The test statistic  $\Delta_n S(X, \Delta_n)$  has been used in Jacod, Lejay and Talay (2008) to test for the full rank.



# Assumptions

- ▶ In contrast to the usual asymptotic theory for high frequency data, we require some stronger assumptions:

$$a_t = a_0 + \int_0^t a_s^{(1)} ds + \int_0^t a_s^{(2)} dW_s,$$

$$\sigma_t = \sigma_0 + \int_0^t \sigma_s^{(1)} ds + \int_0^t \sigma_s^{(2)} dW_s.$$

- ▶ Furthermore, the process  $\sigma^{(2)} \in \mathbb{R}^{d \times d \times d}$  must be diffusions of the same type as  $X$ ,  $a$  and  $\sigma$ .

# An asymptotic decomposition

- ▶ We define for any  $1 \leq l \leq d$

$$\alpha_{i,l}^n = \Delta_n^{-1/2} \sigma_{(i-1)\Delta_n} \Delta_{i+l-1}^n W$$

$$\beta_{i,l}^n = \Delta_n^{-1/2} \Delta_{i+l-1}^n \widehat{W} + a_{(i-1)\Delta_n}$$

$$+ \Delta_n \sigma_{(i-1)\Delta_n}^{(2)} \int_{(i-1)\Delta_n}^{(i-1+l)\Delta_n} (W_s - W_{(i-1)\Delta_n}) dW_s$$

- ▶ With the notation  $\alpha_i^n = (\alpha_{i,1}^n, \dots, \alpha_{i,d}^n)$ ,  $\beta_i^n = (\beta_{i,1}^n, \dots, \beta_{i,d}^n)$ , we deduce the asymptotic relation

$$(\Delta_i^n Z^n / \sqrt{\Delta_n}, \dots, \Delta_{i+d-1}^n Z^n / \sqrt{\Delta_n}) = \underbrace{\alpha_i^n}_{=A} + \underbrace{\Delta_n^{1/2} \beta_i^n}_{=hB} + O_{\mathbb{P}}(\Delta_n).$$

# Consistency

**Theorem:** Under the aforementioned assumptions, we obtain the following results.

(i) As  $n \rightarrow \infty$

$$\Delta_n^{1+R-d} \sum_{i=1}^{[1/\Delta_n]-d+1} \det^2 \left( \Delta_i^n Z^n / \sqrt{\Delta_n}, \dots, \Delta_{i+d-1}^n Z^n / \sqrt{\Delta_n} \right) \\ \xrightarrow{\mathbb{P}} S = \int_0^1 \Gamma(a_s, \sigma_s, \sigma_s^{(2)}) ds > 0.$$

(ii) In particular, we deduce that

$$T_n := \frac{S(Z^n, 2\Delta_n)}{S(Z^n, \Delta_n)} \xrightarrow{\mathbb{P}} 2^{d-R}.$$

# Central limit theorem

**Theorem:** Under the aforementioned assumptions, we obtain the following results.

(i) As  $n \rightarrow \infty$

$$\Delta_n^{-1/2} \left( \Delta_n^{1+R-d} S(Z^n, \Delta_n) - S, (2\Delta_n)^{1+R-d} S(Z^n, 2\Delta_n) - S \right) \\ \xrightarrow{d_{st}} MN \left( 0, \int_0^1 V(a_s, \sigma_s, \sigma_s^{(2)}) ds \right).$$

(ii) In particular, we deduce that

$$\Delta_n^{-1/2} \left( d - \frac{\log T_n}{\log 2} - R \right) \xrightarrow{d_{st}} MN \left( 0, \int_0^1 \Sigma(a_s, \sigma_s, \sigma_s^{(2)}) ds \right),$$

where the asymptotic variance  $\int_0^1 \Sigma(a_s, \sigma_s, \sigma_s^{(2)}) ds$  can be consistently estimated by  $\Sigma_n$ .

## Testing procedure

- ▶ Given a number  $R_0 \in \{0, \dots, d\}$ , let us consider the following null/alternative hypothesis

$$H_0 : R = R_0 \quad \text{vs.} \quad H_1 : R \neq R_0.$$

- ▶ Define the test statistic  $R_n$  by

$$R_n = d - \frac{\log T_n}{\log 2}.$$

- ▶ We obtain that ( $c_\alpha = \alpha$ -quantile of  $\mathcal{N}(0, 1)$ )

$$\mathbb{P}_{H_0} \left( \left| \frac{\Delta_n^{-1/2}(R_n - R_0)}{\sqrt{\Sigma_n}} \right| > c_{1-\frac{\alpha}{2}} \right) \rightarrow \alpha,$$

$$\mathbb{P}_{H_1} \left( \left| \frac{\Delta_n^{-1/2}(R_n - R_0)}{\sqrt{\Sigma_n}} \right| > c_{1-\frac{\alpha}{2}} \right) \rightarrow 1.$$

## Other applications

- ▶ The hypothesis testing

$$H_0 : R = 0 \quad \text{vs.} \quad H_1 : R > 0$$

corresponds to the test

$$H_0 : X = \text{integrated diffusion} \quad \text{vs.} \quad H_1 : X = \text{diffusion}$$

Integrated diffusions appear naturally in the engineering science. We refer to the work of M. Sorensen and A. Gloter for statistical methods.

- ▶ With some more work our method can be applied to the model  $Y = (X, \sigma)$ , where  $X$  is a one-dimensional diffusion with volatility  $\sigma$ .  
Testing

$$H_0 : R \leq 1 \quad \text{vs.} \quad H_1 : R = 2$$

is related to testing the local volatility assumption (see Podolskij and Rosenbaum (2011)). These type of questions are also important in the theory of financial bubbles developed by P. Protter.

# Simulation design

- ▶ We consider the model  $dX_t = a_t dt + \sigma_t dW_t$  with

$$\sigma_t = (1 + (2t - 1)^2) \begin{pmatrix} \cos(tA\pi/2) & \cos(tA\pi/2) \\ \sin(tA\pi/2) & \sin(tA\pi/2) \end{pmatrix},$$

$$a_t = B \begin{pmatrix} 1 + \sin(tA\pi/2) \\ 1 + \cos(tA\pi/2) \end{pmatrix}$$

- ▶ The frequency is given as

$$\Delta_n = \frac{1}{25000}$$

- ▶ We perform 5000 replications to uncover the finite sample properties.

## Simulation results at level $\alpha = 0.05$

$B$	$A$	2d moment	4th moment	$R = 0$	$R = 1$	$R = 2$
0	0	1.01	2.99	1.00	0.050	1.00
0	5	1.00	2.94	1.00	0.049	1.00
0	10	1.01	3.36	1.00	0.062	1.00
3	0	1.02	3.26	1.00	0.050	1.00
3	5	1.02	3.20	1.00	0.052	1.00
3	10	1.01	3.03	1.00	0.049	1.00
12	0	0.98	2.88	1.00	0.049	1.00
12	3	1.02	3.13	1.00	0.052	1.00
12	10	1.01	2.99	1.00	0.050	1.00



Thank you!